

TABLE OF CONTENTS

	Page
ACKNOWLEDGEMENT	iii
ABSTRACT (ENGLISH)	v
ABSTRACT (THAI)	viii
LIST OF TABLES	xiv
LIST OF FIGURES	xvi
ABBREVIATIONS AND SYMBOLS	xxvii
CHAPTER 1 INTRODUCTION	1
CHAPTER 2 LITERATURE REVIEW	5
2.1 Perovskite Ferroelectrics	5
2.2 Lead Zirconate Titanate (PZT)	6
2.3 Lead Magnesium Niobate (PMN)	19
2.4 Lead Zirconate Titanate - Lead Magnesium Niobate	27
CHAPTER 3 EXPERIMENTAL PROCEDURE	31
3.1 Samples Preparation	31
3.1.1 Powder Preparation	31
3.1.2 Ceramic Fabrication	36

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	Page
3.2 Sample Characterization	37
3.2.1 Differential Thermal Analysis (DTA) and Thermogravimetric Analysis (TGA)	37
3.2.2 X-ray Diffraction (XRD)	38
3.2.3 Densification Measurement	39
3.2.4 Scanning Electron Microscopy (SEM)	40
3.2.5 Transmission Electron Microscopy (TEM)	41
3.2.6 Dielectric Measurement	43
CHAPTER 4 RESULTS AND DISCUSSION (PART I):	45
Lead Zirconate Titanate (PZT)	
4.1 Zirconium Titanate Powder	45
4.1.1 Thermal Analysis	45
4.1.2 Phase Analysis	46
4.1.3 Morphological Analysis	51
4.2 Lead Zirconate Titanate Powder	53
4.2.1 Thermal Analysis	53
4.2.2 Phase Analysis	54
4.2.3 Morphological Analysis	61

	Page
4.3 Lead Zirconate Titanate Ceramic	62
4.3.1 Phase Analysis	62
4.3.2 Densification and Microstructural Analysis	69
4.3.3 Dielectric Properties	85
CHAPTER 5 RESULTS AND DISCUSSION (PART II):	93
Lead Magnesium Niobate (PMN)	
5.1 Magnesium Niobate Powder	93
5.1.1 Thermal Analysis	93
5.1.2 Phase Analysis	94
5.1.3 Morphological Analysis	102
5.2 Lead Magnesium Niobate Powder	103
5.2.1 Thermal Analysis	104
5.2.2 Phase Analysis	105
5.2.3 Morphological Analysis	112
5.3 Lead Magnesium Niobate Ceramic	115
5.3.1 Phase Analysis	115
5.3.2 Densification and Microstructural Analysis	121
5.3.3 Dielectric Properties	129

	Page
CHAPTER 6 RESULTS AND DISCUSSION (PART III):	135
Lead Zirconate Titanate–Lead Magnesium Niobate	
(PZT-PMN) Ceramics	
6.1 Phase Analysis	135
6.2 Densification and Microstructural Analysis	147
6.3 Dielectric Properties	162
6.4 Microstructure and Electrical Property Relationships	174
CHAPTER 7 CONCLUSIONS AND SUGGESTIONS FOR FURTHER	185
WORK	
7.1 Conclusions	185
7.2 Suggestions for Further Work	186
REFERENCES	188

LIST OF TABLES

Table	Page
2.1 Influence of processing parameters on PMN formation.	25
2.2 Effect of nonstoichiometry on the dielectric properties of PMN ceramics.	26
3.1 Specifications of the starting materials used in this study.	32
4.1 Calculated PZT phases as a function of calcination conditions.	60
4.2 Chemical compositions of the PZT ceramic (sintered at 1275 °C for 4 h with heating/cooling rates of 10 °C/min) from EDS analysis.	67
4.3 Effect of sintering temperatures on phase formation and densification in sintered PZT ceramics.	71
4.4 Effect of dwell time and heating/cooling rates on phase formation and densification in PZT ceramics sintered at 1250 °C.	72
4.5 Physical and dielectric properties of PZT ceramics sintered at various temperatures for 4 h with heating/cooling rates of 10 °C/min.	89
5.1 Calculated MN powders as a function of calcination conditions.	101
5.2 Chemical compositions of the PMN powders (calcined at 750 °C and 1000 °C) from EDX analyser.	114
5.3 Chemical compositions of the PMN ceramics (sintered at 1250 °C for 4 h with heating/cooling rates of 10 °C/min) from EDX analyser.	118
5.4 Effect of sintering conditions on phase formation of PMN ceramics.	120

Table	Page
5.5 Effect of sintering conditions on phase formation and densification in sintered PMN ceramics.	124
5.6 Physical and dielectric properties of PMN ceramics sintered at various temperatures for 4 h with heating/cooling rates of 10 °C/min.	132
6.1 Phase formation of x PZT-(1- x)PMN ceramics sintered at various temperatures.	136
6.2 Density* and shrinkage** of x PZT-(1- x)PMN ceramics sintered at various temperatures.	149
6.3 Grain size* of x PZT-(1- x)PMN ceramics sintered at various temperatures.	155
6.4 Dielectric properties of x PZT-(1- x)PMN ceramics taken from data measurement at 1 kHz and room temperature.	175

LIST OF FIGURES

Figure		Page
1.1	Variety of ferroelectric ceramics used in piezoelectric and electrostrictive applications, such as actuators, sensors and capacitors.	1
2.1	A cubic ABO_3 perovskite-type unit cell with BO_6 octahedra.	6
2.2	Phase stabilities in the $Pb(Zr_xTi_{1-x})O_3$ system.	8
2.3	The high temperature pseudo-binary system of PZ-PT.	9
2.4	The ternary system $PbO-TiO_2-ZrO_2$ at 1100 °C.	10
2.5	Phases in the system $2PbO-TiO_2-ZrO_2$.	11
2.6	PZT phase diagram around the MPB proposed by Noheda et al.	14
2.7	Fracture surface of PZT ceramics sintered at different temperatures (a) 950 °C, (b) 1000 °C, (c) 1050 °C, (d) 1100 °C and (e) 1150 °C.	15
2.8	Dependence of relative permittivity of PZT ceramics on chemical compositions at room temperature.	17
2.9	Ternary phase diagram of the $PbO-MgO-Nb_2O_5$ system at 1000 °C. The black domain represents the pyrochlore (Py) solid-solution range, the light gray area correspond to diphasic domains, and the dark gray area represents the extent of the liquidus at 1000 °C.	21
2.10	As-fired surface of PMN ceramic indicating the existence of pyrochlore (Pyro) and MgO phases.	24

Figure	Page
2.11 Compositions studied in the system $x\text{PMN}-y\text{PT}-z\text{PZ}$ and phase boundaries at room temperature.	29
3.1 Mixing and calcination processes or MCP (step 1-6) for B-site precursor preparation.	34
3.2 Flow chart for the preparation of PZT and PMN powders.	35
3.3 Flow chart for the fabrication of PZT-PMN ceramics.	35
3.4 Sample arrangement for the sintering process.	36
3.5 Differential thermal analysis (Stanton Redcroft DTA 673-4).	37
3.6 Thermogravimetric analysis (Perkin Elmer TGA7)	38
3.7 X-ray diffractometer (Philips Model X-pert).	39
3.8 Scanning electron microscope (SEM, Camscan II).	41
3.9 Transmission electron microscope (TEM, Philips Tecnai 20).	42
3.10 Cross section view of the jig and details of arrangement.	44
4.1 A DTA curve for the mixture of $\text{ZrO}_2 - \text{TiO}_2$ powders.	46
4.2 XRD patterns of ZT powder calcined at various temperatures for 4 h with heating/cooling rates of $20\text{ }^\circ\text{C}/\text{min}$.	48
4.3 XRD patterns of ZT powder calcined at $1300\text{ }^\circ\text{C}$ with heating/cooling rates of $20\text{ }^\circ\text{C}/\text{min}$ for various dwell times.	49
4.4 XRD patterns of ZT powder calcined at $1300\text{ }^\circ\text{C}$ for 4 h with various heating/cooling rates.	50

Figure	Page
4.5 SEM profile of the calcined ZT powders at (a) 1100 °C, (b) 1175 °C, (c) 1200 °C and (d) 1300 °C for 4 h with heating/cooling rate of 20 °C/min.	52
4.6 A DTA curve for the mixture of PbO-ZrTiO ₄ powders.	54
4.7 Powder XRD patterns of the calcined PZT powders at various calcination temperatures for 2 h with heating/cooling rates of 20 °C/min.	56
4.8 Computerised JCPDS data-matching confirms that formation of both tetragonal and rhombohedral PZT phases in the calcined powder.	57
4.9 Enlarged XRD peaks for the tetragonal (T) and rhombohedral (R) phases as a function of calcination temperatures (dotted line in Fig. 4.7).	57
4.10 Computerised JCPDS data-matching confirms that formation of the single-phase tetragonal PZT.	58
4.11 Powder XRD patterns of the calcined PZT powders at 760 °C with heating/cooling rates of 20 °C/min for various dwell times.	58
4.12 Powder XRD patterns of the calcined PZT powders at 760 °C for 2 h with various heating/cooling rates.	59
4.13 SEM micrographs of the PZT powders calcined at (a) 700 °C, (b) 740 °C, (c) 760 °C and (d) 950 °C.	61

Figure	Page
4.14 XRD patterns of PZT ceramics sintered at various temperatures for 4 h with heating/cooling rates of 10 °C/min.	64
4.15 EDS analysis results in three different grains of PZT ceramic sintered at 1275 °C for 4 h with heating/cooling rates of 10 °C/min.	66
4.16 XRD patterns of PZT ceramics sintered at 1250 °C with heating/cooling rates of 10 °C/min for various dwell times.	67
4.17 XRD patterns of PZT ceramics sintered at 1250 °C for 4 h with various heating/cooling rates.	68
4.18 Variation of density with sintering temperature for PZT ceramics sintered for 4 h with heating/cooling rates of 10 °C/min.	73
4.19 Porosity versus sintering temperature for PZT ceramics sintered for 4 h with heating/cooling rates of 10 °C/min.	73
4.20 Dependence of linear shrinkage and weight loss on sintering temperature for PZT ceramics.	76
4.21 SEM micrograph of PZT surface sintered at 1320 °C for 4 h with heating/cooling rates of 10 °C/min.	76
4.22 SEM micrographs of free surface of PZT ceramics sintered at (a) 1150 °C, (b) 1200 °C, (c) 1225 °C, (d) 1250 °C and (e) 1320 °C.	78
4.23 SEM micrographs of fracture surface of PZT ceramics sintered at (a) 1150 °C, (b) 1200 °C, (c) 1225 °C, (d) 1250 °C and (e) 1320 °C.	79

Figure		Page
4.24	SEM micrographs of PZT ceramics sintered at 1250 °C for 4 h with heating/cooling rates of (a) 1, (b) 5, (c) 10, (d) 20 and (e) 30 °C/min.	80
4.25	SEM micrographs of PZT ceramics sintered at 1250 °C with heating/cooling rates of 30 °C/min for (a) 2, (b) 4, (c) 6 and (d) 8 h.	81
4.26	TEM micrograph showing (a) dark-field images from grains of PZT ceramics and (b-c) the corresponding selected area electron diffraction (SAED) patterns of grains A, B and C.	84
4.27	The temperature dependence of the dielectric constant and dissipation factor of the PZT ceramics sintered at (a) 1150 °C, (b) 1200 °C, (c) 1225 °C, (d) 1250 °C and (e) 1275 °C, for 4 h with heating/cooling rates of 10 °C/min.	87
4.28	Comparison of dielectric constant at room temperature and T_c and an average grain size for different sintering temperatures.	92
4.29	The average grain size versus (a) dielectric constant and dissipation factor at room temperature and (b) maximum dielectric constant at T_c and Curie temperature of PZT ceramics.	92
5.1	A DTA curve for the mixture of MgO-Nb ₂ O ₅ powders.	94
5.2	XRD patterns of MN powder calcined at various temperatures for 2 h with heating/cooling rates of 10 °C/min.	96
5.3	XRD patterns of the powders calcined at 1050 °C with heating/cooling rates of 10 °C/min for various dwell times.	97

Figure		Page
5.4	Computerised JCPDS data-matching confirms that formation of both MgNb_2O_6 and $\text{Mg}_{0.66}\text{Nb}_{11.33}\text{O}_{15}$ phases in the powder calcined at $1050\text{ }^\circ\text{C}$ for 6 h with heating/cooling rates of $10\text{ }^\circ\text{C}/\text{min}$.	98
5.5	XRD patterns of the powders calcined at $1050\text{ }^\circ\text{C}$ for 2 h with various heating/cooling rates.	99
5.6	SEM micrographs of the MN powders calcined at (a) $800\text{ }^\circ\text{C}$, (b) $1000\text{ }^\circ\text{C}$, (c) $1050\text{ }^\circ\text{C}$ and (d) $1100\text{ }^\circ\text{C}$, all for 2 h with heating/cooling rates of $10\text{ }^\circ\text{C}/\text{min}$.	103
5.7	TG-DTA curves for the mixture of $\text{PbO-MgNb}_2\text{O}_6$ powder.	105
5.8	Powder XRD patterns of the samples calcined at various temperatures for 2 h with heating/cooling rates of $10\text{ }^\circ\text{C}/\text{min}$.	108
5.9	Computerised JCPDS data-matching indicates the possibility of peaks overlapping between $\text{Pb}_5\text{Nb}_4\text{O}_{15}$ and $\text{Pb}_{1.83}\text{Nb}_{1.71}\text{Mg}_{0.29}\text{O}_{6.39}$ phases in the powders calcined at various temperatures for 2 h with heating/cooling rates of $10\text{ }^\circ\text{C}/\text{min}$.	109
5.10	Powder XRD patterns of the samples calcined at $750\text{ }^\circ\text{C}$ with heating/cooling rates of $10\text{ }^\circ\text{C}/\text{min}$ for various dwell times.	110
5.11	Powder XRD patterns of the samples calcined at $750\text{ }^\circ\text{C}$ for 2 h with various heating/cooling rates.	111

Figure	Page
5.12 SEM micrographs of the powders calcined at (a) 600 °C, (b) 750 °C, (c) 800 °C, (d) 900 °C and (e) 1000 °C, for 2 h with heating/cooling rates of 10 °C/min.	113
5.13 SEM micrographs and X-ray microanalysis spectra from the PMN powders calcined at (a) 750 °C and (b) 1000 °C.	114
5.14 XRD patterns of PMN ceramics sintered at various temperatures for 4 h with heating/cooling rates of 10 °C/min.	116
5.15 SEM micrographs and X-ray microanalysis spectra from different grains of PMN ceramic.	117
5.16 XRD patterns of PMN ceramics sintered at 1275 °C with heating/cooling rates of 10 °C/min for various dwell times.	118
5.17 XRD patterns of PMN ceramics sintered at 1275 °C for 4 h with various heating/cooling rates.	119
5.18 Variation of density and porosity with sintering temperature for PMN ceramics sintered for 4 h with heating/cooling rates of 10 °C/min.	122
5.19 Dependence of shrinkage and weight loss on sintering temperature for PMN ceramics.	123
5.20 SEM micrographs of free surface of PMN ceramics sintered at (a) 1150 °C, (b) 1225 °C, (c) 1250 °C and (d) 1275 °C, for 4 h with heating/cooling rates of 10 °C/min.	125

Figure	Page
5.21 SEM micrographs of fracture surface of PMN ceramics sintered at (a) 1150 °C, (b) 1225 °C, (c) 1250 °C and (d) 1275 °C, for 4 h with heating/cooling rates of 10 °C/min.	126
5.22 SEM micrographs of PMN ceramics sintered at 1275 °C with heating/cooling rates of 10 °C/min for (a) 1, (b) 2, (c) 4 and (d) 6 h.	127
5.23 SEM micrographs of PMN ceramics sintered at 1275 °C for 4 h with heating/cooling rates of (a) 5, (b) 10, (c) 20 and (d) 30°C/min.	128
5.24 Dielectric constant and dissipation factor of PMN ceramics sintered at (a) 1150 °C, (b) 1200 °C, (c) 1225 °C, (d) 1250 °C and (e) 1275 °C, for 4 h with heating/cooling rates of 10 °C/min.	130
5.25 The average grain size versus the dielectric constant and dissipation factor at room temperature of PMN ceramics.	134
5.26 The average grain size versus the maximum dielectric constant and $T(\epsilon_{r,max})$ of PMN ceramics.	134
6.1 XRD patterns of the x PZT-(1- x)PMN ceramics sintered at their optimum conditions.	139
6.2 Selected region of the diffraction patterns for x PZT-(1- x)PMN ceramics.	140
6.3 Variation of cell parameters in the x PZT-(1- x)PMN system.	140

Figure	Page
6.4 XRD patterns of 0.9PZT-0.1PMN ceramics sintered at various temperatures for 4 h with heating/cooling rates of 10 °C/min.	142
6.5 XRD patterns of 0.7PZT-0.3PMN ceramics sintered at various temperatures for 4 h with heating/cooling rates of 10 °C/min.	143
6.6 XRD patterns of 0.5PZT-0.5PMN ceramics sintered at various temperatures for 4 h with heating/cooling rates of 10 °C/min.	144
6.7 XRD patterns of 0.3PZT-0.7PMN ceramics sintered at various temperatures for 4 h with heating/cooling rates of 10 °C/min.	145
6.8 XRD patterns of 0.1PZT-0.9PMN ceramics sintered at various temperatures for 4 h with heating/cooling rates of 10 °C/min.	146
6.9 Dependence of (a) bulk densities and (b) shrinkage on sintering temperature for x PZT-(1- x)PMN ceramics.	150
6.10 SEM micrographs of 0.9PZT-0.1PMN ceramics sintered for 4 h at (a) 1150 °C, (b) 1200 °C, (c) 1225 °C, (d) 1250 °C, (e) 1275 °C and (f) 1290 °C.	156
6.11 SEM micrographs of the 0.7PZT-0.3PMN ceramics sintered for 4 h at (a) 1225 °C, (b) 1250 °C, (c) 1275 °C, (d) 1290 °C and (e) 1320 °C.	157
6.12 SEM micrographs of the 0.5PZT-0.5PMN ceramics sintered for 4 h at (a) 1250 °C, (b) 1275 °C, (c) 1290 °C and (d) 1320 °C.	158

Figure	Page
6.13 SEM micrographs of the 0.3PZT-0.7PMN ceramics sintered for 4 h at (a) 1150 °C, (b) 1200 °C, (c) 1225 °C, (d) 1250 °C, (e) 1275 °C and (f) 1290 °C.	159
6.14 SEM micrographs of the 0.1PZT-0.9PMN ceramics sintered for 4 h at (a) 1200 °C, (b) 1225 °C, (c) 1250 °C, (d) 1275 °C, (e) 1290 °C and (f) 1320 °C.	160
6.15 SEM micrograph of polished surface of 0.1PZT-0.9PMN sintered at 1275 °C for 4 h with heating/cooling rates of 10 °C/min (darker grains are pyrochlore phases).	161
6.16 Dielectric constant and dielectric loss as a function of temperature of 0.9PZT-0.1PMN samples sintered at (a) 1200 °C, (b) 1225 °C, (c) 1250 °C, (d) 1275 °C and (e) 1290 °C.	165
6.17 Dielectric constant of 0.9PZT-0.1PMN ceramics sintered at different sintering temperature (measured at 1 kHz).	166
6.18 Dielectric constant and dielectric loss as a function of temperature of 0.7PZT-0.3PMN samples sintered at (a) 1225 °C, (b) 1250 °C, (c) 1275 °C, (d) 1290 °C and (e) 1320 °C.	167
6.19 Dielectric constant and dielectric loss as a function of temperature of 0.5PZT-0.5PMN samples sintered at (a) 1225 °C, (b) 1250 °C, (c) 1275 °C, (d) 1290 °C and (e) 1320 °C.	169

Figure	Page
6.20 Dielectric constant and dielectric loss as a function of temperature of 0.3PZT-0.7PMN samples sintered at (a) 1200 °C, (b) 1225 °C, (c) 1250 °C, (d) 1275 °C and (e) 1290 °C.	171
6.21 Dielectric constant and dielectric loss as a function of temperature of 0.1PZT-0.9PMN samples sintered at (a) 1200 °C, (b) 1225 °C, (c) 1250 °C and (d) 1275 °C.	173
6.22 Room temperature dielectric constant of x PZT-(1- x)PMN ceramics as a function of x .	176
6.23 The dielectric constant at room temperature versus average grain size of x PZT-(1- x)PMN ceramics.	177
6.24 The maximum dielectric constant versus average grain size of x PZT-(1- x)PMN ceramics.	177
6.25 Temperature dependence of (a) the dielectric constant and (b) dielectric loss of x PZT-(1- x)PMN ceramics.	179
6.26 Temperature of dielectric constant maximum of the x PZT-(1- x)PMN ceramics as a function of PZT concentration.	181

ABBREVIATIONS AND SYMBOLS

BT	Barium titanate
PZT	Lead zirconate titanate
PMN	Lead magnesium niobate
MPB	Morphotropic phase boundary
ZT	Zirconium titanate
MN	Magnesium niobate
Q_m	Electrostrictive coefficient
$\tan \delta$	Dissipation factor, dielectric loss
k_p	Planar coupling factor
ϵ_r	Dielectric constant, relative permittivity
$\epsilon_r(T_R)$	Dielectric constant at room temperature
$\epsilon_{r,max}$	Maximum dielectric constant
ϵ_0	Permittivity of the free space
PT	Lead titanate
FE	Ferroelectric
AFE	Antiferroelectric
PZ	Lead zirconate
P_c	Paraelectric cubic phase
A_T	Antiferroelectric tetragonal phase
A_o	Antiferroelectric orthorhombic phase

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$F_R(HT)$	High temperature ferroelectric rhombohedral phase
$F_R(LT)$	Low temperature ferroelectric rhombohedral phase
F_T	Ferroelectric tetragonal phase
DTA	Differential thermal analysis
XRD	X-ray diffraction
PC	(Pseudo)cubic phase
C	Cubic phase
T	Tetragonal phase
M	Monoclinic phase
R_{HT}	Rhombohedral phase at high temperature
R_{LT}	Rhombohedral phase at low temperature
T_c	Curie temperature
Pyro	Pyrochlore phase
IR	Insulation resistance
T_{max} or $T(\epsilon_{r,max})$	Temperature at maximum dielectric constant
SEM	Scanning electron microscope / microscopy
MCP	Mixing and calcination processes
PVA	Polyvinyl alcohol
TEM	Transmission electron microscope / microscopy
$T(\tan \delta_{max})$	Temperature at maximum dielectric loss